

MOSFET

StrongIRFET™ 2 Power-Transistor

Features

- Optimized for a wide range of applications
 N-Channel, normal level
 100% avalanche tested

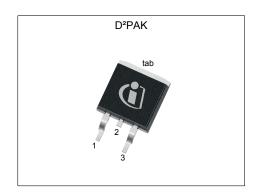
- Pb-free lead plating; RoHS compliant
 Halogen-free according to IEC61249-2-21

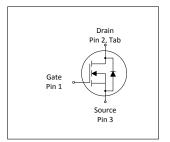
Product validation

Qualified according to JEDEC Standard

Table 1 **Key Performance Parameters**

- and the state of							
Parameter	Value	Unit					
V _{DS}	80	V					
R _{DS(on),max}	1.95	mΩ					
I_{D}	166	A					
Q _{oss}	145	nC					
Q_{G}	124	nC					











Type / Ordering Code	Package	Marking	Related Links
IPB019N08NF2S	PG-TO263-3	019N08NS	-

StrongIRFETTM 2 Power-Transistor IPB019N08NF2S



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StrongIRFET[™] 2 Power-Transistor **IPB019N08NF2S**



1 Maximum ratings at T_A =25 °C, unless otherwise specified

Table 2 Maximum ratings

Danamatan	0		Value	s		
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current ¹⁾	I D	- - -	- - -	166 128 128 31	A	$V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =10 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =6 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =10V, $T_{\rm A}$ =25°C, $R_{\rm thJA}$ =40°C/W ²)
Pulsed drain current ³⁾	I _{D,pulse}	-	-	664	Α	T _A =25 °C
Avalanche energy, single pulse ⁴⁾	E AS	-	-	593	mJ	$I_{\rm D}$ =100 A, $R_{\rm GS}$ =25 Ω
Gate source voltage	V _{GS}	-20	-	20	V	-
Power dissipation	P _{tot}	-	-	250 3.8	W	T _C =25 °C T _A =25 °C, R _{thJA} =40 °C/W ²⁾
Operating and storage temperature	$T_{\rm j},~T_{\rm stg}$	-55	-	175	°C	-

2 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
Parameter	Symbol	Min.	Тур.	Max.	Ullit	Note / Test Condition
Thermal resistance, junction - case	R _{thJC}	-	-	0.6	°C/W	-
Thermal resistance, junction - ambient, 6 cm² cooling area²)		-	-	40	°C/W	-
Thermal resistance, junction - ambient, minimal footprint	R _{thJA}	_	-	62	°C/W	-

¹⁾ Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature as specified. For other case temperatures please refer to Diagram 2. De-rating will be required based on the actual environmental conditions. $^{2)}$ Device on 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm 2 (one layer, 70 μ m thick) copper area for drain

connection. PCB is vertical in still air.

3) See Diagram 3 for more detailed information

⁴⁾ See Diagram 13 for more detailed information

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3 Electrical characteristics at T_j =25 °C, unless otherwise specified

Table 4 **Static characteristics**

Danamatan	Ob o.l		Value	S			
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Drain-source breakdown voltage	V _{(BR)DSS}	80	-	-	V	V _{GS} =0 V, I _D =1 mA	
Gate threshold voltage	$V_{\rm GS(th)}$	2.2	3.0	3.8	V	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 194 \ \mu {\rm A}$	
Zero gate voltage drain current	I _{DSS}	-	0.1 10	1 100	μΑ	V _{DS} =80 V, V _{GS} =0 V, T _i =25 °C V _{DS} =80 V, V _{GS} =0 V, T _j =125 °C	
Gate-source leakage current	I _{GSS}	-	10	100	nA	V _{GS} =20 V, V _{DS} =0 V	
Drain-source on-state resistance	R _{DS(on)}	-	1.6 2.0	1.95 2.6	mΩ	V _{GS} =10 V, I _D =100 A V _{GS} =6 V, I _D =50 A	
Gate resistance	R _G	-	1.2	-	Ω	-	
Transconductance ¹⁾	g fs	108	-	-	S	$ V_{DS} \ge 2 I_D R_{DS(on)max}, I_D = 100 A$	

Table 5 **Dynamic characteristics**

Davamatar	Cumbal	Values			11	Nata / Table Open distant
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	Ciss	-	8700	-	pF	V _{GS} =0 V, V _{DS} =40 V, <i>f</i> =1 MHz
Output capacitance	Coss	-	1400	-	pF	V _{GS} =0 V, V _{DS} =40 V, f=1 MHz
Reverse transfer capacitance	C _{rss}	-	61	-	pF	V _{GS} =0 V, V _{DS} =40 V, <i>f</i> =1 MHz
Turn-on delay time	t _{d(on)}	-	21	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G,ext}$ =1.6 Ω
Rise time	t _r	-	62	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G,ext}$ =1.6 Ω
Turn-off delay time	$t_{\sf d(off)}$	-	50	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G,ext}$ =1.6 Ω
Fall time	t _f	-	26	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G,ext}$ =1.6 Ω

Gate charge characteristics²⁾ Table 6

Parameter	Symbol		Values			Note / Test Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q _{gs}	-	40	-	nC	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =100 A, $V_{\rm GS}$ =0 to 10 V
Gate charge at threshold	$Q_{g(th)}$	-	26	-	nC	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =100 A, $V_{\rm GS}$ =0 to 10 V
Gate to drain charge	Q_{gd}	-	26	-	nC	V _{DD} =40 V, I _D =100 A, V _{GS} =0 to 10 V
Switching charge	Q _{sw}	-	40	-	nC	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =100 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total ¹⁾	Qg	-	124	186	nC	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =100 A, $V_{\rm GS}$ =0 to 10 V
Gate plateau voltage	V _{plateau}	-	4.6	-	V	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =100 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total, sync. FET	Q _{g(sync)}	-	107	-	nC	V _{DS} =0.1 V, V _{GS} =0 to 10 V
Output charge	Qoss	-	145	-	nC	V _{DS} =40 V, V _{GS} =0 V

 $^{^{1)}}$ Defined by design. Not subject to production test. $^{2)}$ See "Gate charge waveforms" for parameter definition

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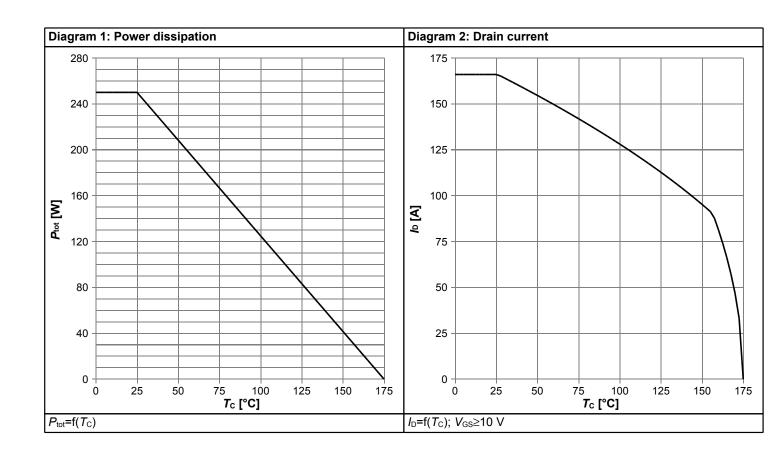


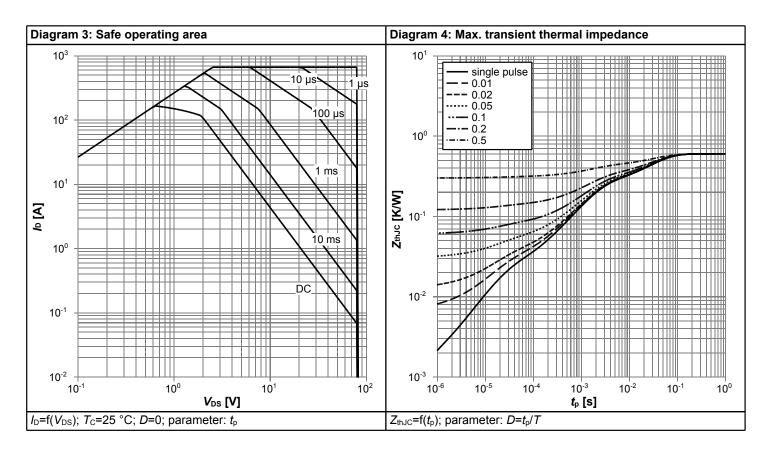
Table 7 Reverse diode

Damana dan	Symbol		Values			Nata / Tank Candikina
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode continuous forward current	Is	-	-	131	Α	<i>T</i> _C =25 °C
Diode pulse current	I _{S,pulse}	-	-	664	Α	<i>T</i> _C =25 °C
Diode forward voltage	V _{SD}	-	0.88	1.2	V	V _{GS} =0 V, I _F =100 A, T _j =25 °C
Reverse recovery time	t _{rr}	-	44	-	ns	V_R =40 V, I_F =100 A, di_F/dt =500 A/ μ s
Reverse recovery charge	Qrr	-	285	-	nC	V_R =40 V, I_F =100 A, di_F/dt =500 A/ μ s

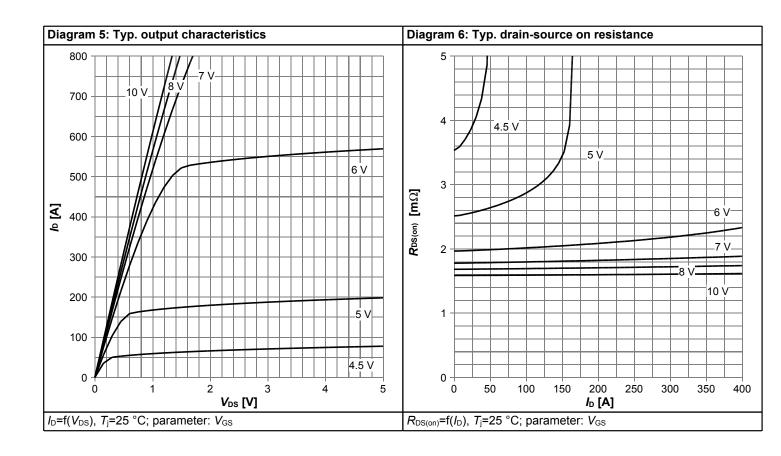


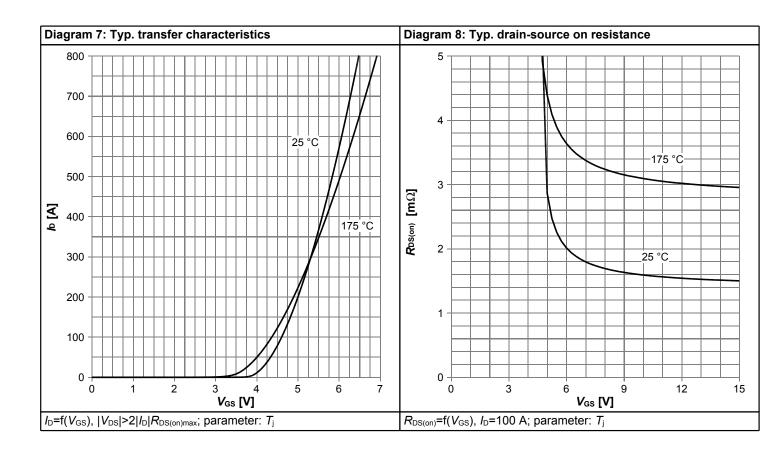
4 Electrical characteristics diagrams



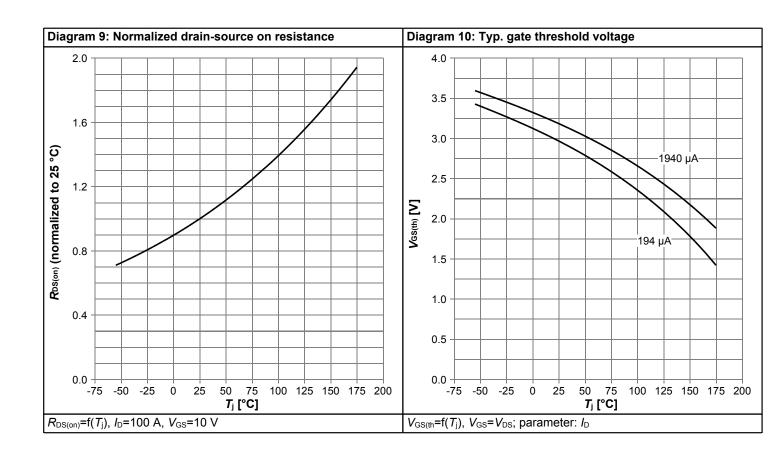


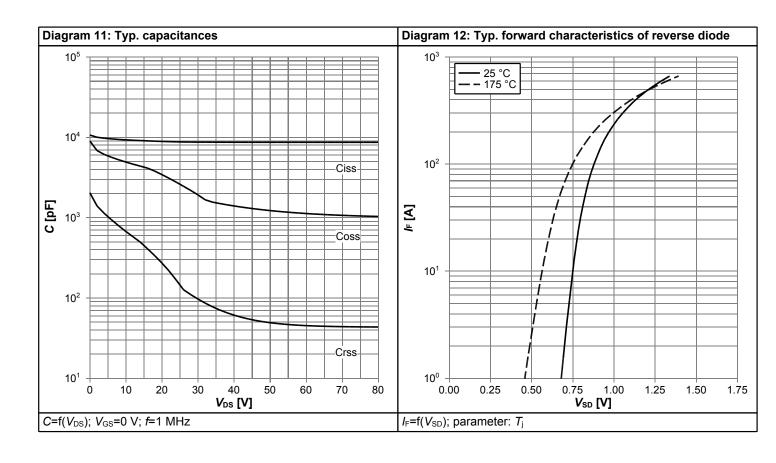




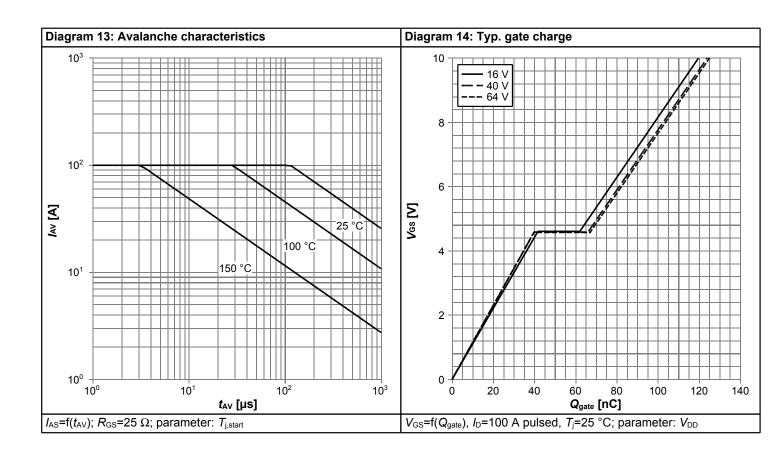


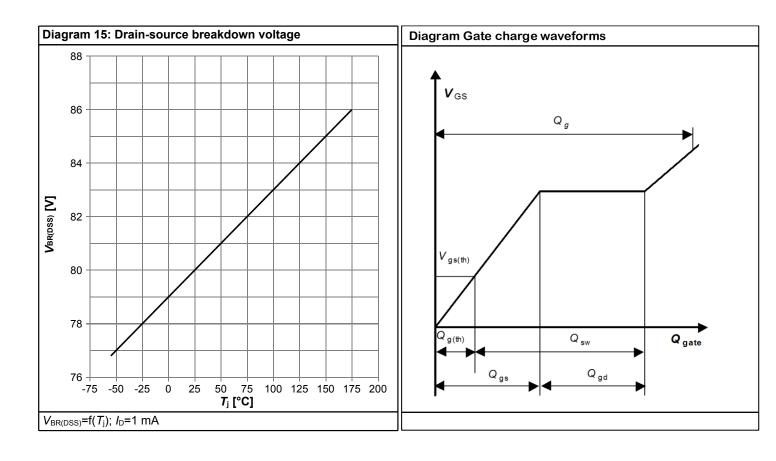






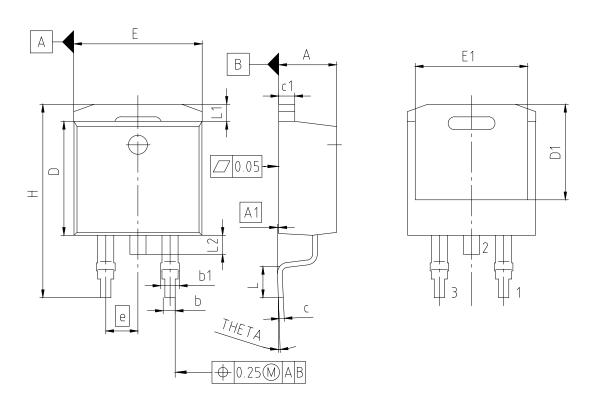








5 Package Outlines



PACKAGE - GROUP NUMBER:	PG-TO26	PG-TO263-3-U02					
DIMENSIONS	MILLIMETERS						
DIMENSIONS	MIN.	MAX.					
Α	4.06	4.83					
A1	0.00	0.25					
b	0.51	1.00					
b1	1.07	1.78					
С	0.30	0.73					
c1	1.14	1.65					
D	8.38	9.65					
D1	6.60	7.50					
E	9.65	10.67					
E1	6.22	8.70					
е	2.	54					
N	3						
Н	14.60	15.88					
L	1.52	2.60					
L1	1.05	1.68					
L2	1.35	1.78					
THETA	-9.00°	8.00°					

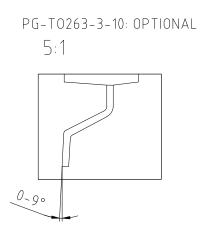


Figure 1 Outline PG-TO263-3, dimensions in mm

StrongIRFET[™] 2 Power-Transistor IPB019N08NF2S



Revision History

IPB019N08NF2S

Revision: 2022-09-23, Rev. 2.0

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.0	2022-09-23	Release of final version

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Final Data Sheet 11 Rev. 2.0, 2022-09-23